

# GSM3106XF

## 30V N-Channel MOSFETs

### Product Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

These devices are well suited for high efficiency fast switching applications.

### Features

- 30V, 60A,  $R_{DS(ON)} < 6m\Omega @ V_{GS}=10V$
- High Power and current handling capability
- Lead free product is acquired
- DFN5x6-8L package design

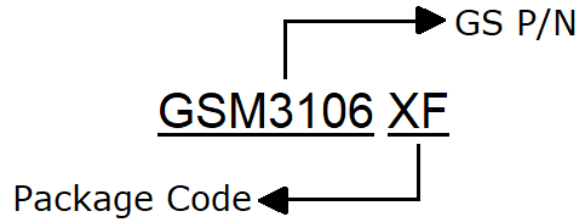
### Applications

- MB / VGA / Vcore
- POL Applications
- SMPS 2nd SR

### Packages & Pin Assignments

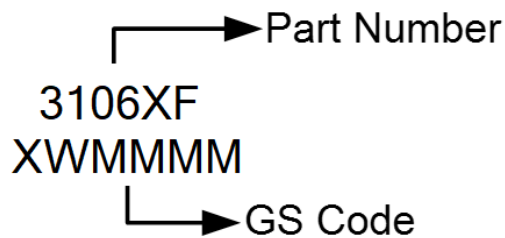
GSM3106XF (DFN5x6-8L)	
<p>Top View</p>	
Pin	Description
1	Source
2	Source
3	Source
4	Gate
5	Drain
6	Drain
7	Drain
8	Drain

## Ordering Information



Part Number	Package	Quantity
GSM3106XF	DFN5x6-8L	3000pcs

## Marking Information



## Absolute Maximum Ratings

$T_A=25^{\circ}\text{C}$  Unless otherwise noted

Symbol	Parameter	Typical	Unit
$V_{DS}$	Drain-Source Voltage	30	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Continuous Drain Current	$T_C=25^{\circ}\text{C}$ <sup>1</sup>	60
		$T_C=70^{\circ}\text{C}$	48
$I_{DM}$	Pulsed Drain Current <sup>2</sup>	100	A
$E_{AS}$	Single Pulse Avalanche Energy, $L = 0.5\text{mH}$ <sup>3</sup>	30	mJ
$P_D$	Power Dissipation $T_C=25^{\circ}\text{C}$	40	W
	Power Dissipation $T_C=70^{\circ}\text{C}$	27	W
$T_J$	Operating Junction Temperature Range	-55 to +150	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature Range	-55 to +150	$^{\circ}\text{C}$
$R_{\theta JC}$	Thermal Resistance-Junction to Case	3	$^{\circ}\text{C}/\text{W}$

Note :

- 1.The maximum current rating is package limited..
- 2.Repetitive Rating: Pulse width limited by maximum junction temperature.
3. $E_{AS}$  ratings are based on low frequency and duty cycles to keep  $T_J = +25^{\circ}\text{C}$ .

## Electrical Characteristics

T<sub>A</sub>=25°C Unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static characteristics</b>						
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	30			V
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA	1.0		2.5	V
I <sub>GSS</sub>	Gate Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V			±100	nA
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V			1	uA
V <sub>SD</sub>	Diode Forward Voltage <sup>3</sup>	V <sub>GS</sub> =0V, I <sub>S</sub> =2A			1	V
R <sub>DS(on)</sub>	Drain-Source On-Resistance <sup>3</sup>	V <sub>GS</sub> =10V, I <sub>D</sub> =20A		4.8	6	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =10A		6.8	9.8	
<b>Gate charge characteristics</b>						
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =15V, V <sub>GS</sub> =10V, I <sub>D</sub> =9A		16.7		nC
Q <sub>gs</sub>	Gate-Source Charge			2.2		
Q <sub>gd</sub>	Gate-Drain Charge			3.5		
<b>Dynamic characteristics</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =15V, V <sub>GS</sub> =0V, f=1.0MHz		1155		pF
C <sub>oss</sub>	Output Capacitance			456		
C <sub>rss</sub>	Reverse Transfer Capacitance			72		
t <sub>d(on)</sub>	Turn-On Time	V <sub>DS</sub> =15V, V <sub>GS</sub> =10V, R <sub>g</sub> =3Ω, I <sub>D</sub> =9A		3.5		ns
t <sub>r</sub>	Rise Time			5.5		
t <sub>d(off)</sub>	Turn-Off Time			13.5		
t <sub>f</sub>	Fall Time			4.6		
R <sub>g</sub>	Gate Resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1.0MHz		1.6		Ω

## Typical Performance Characteristics

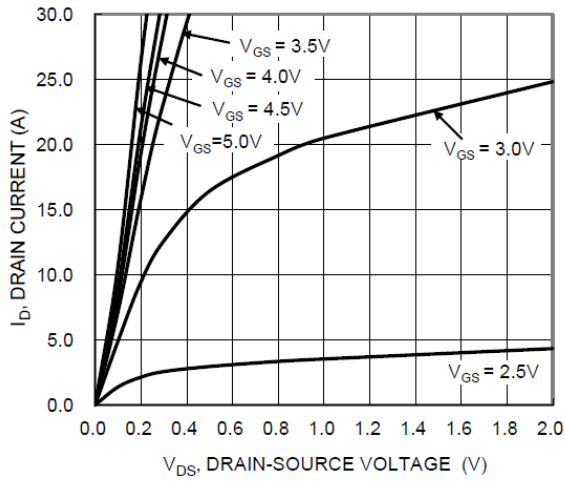


Figure 1. Output Characteristics

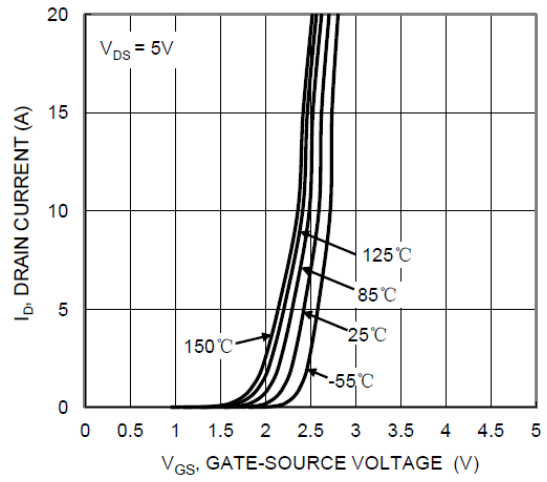


Figure 2. Transfer Characteristics

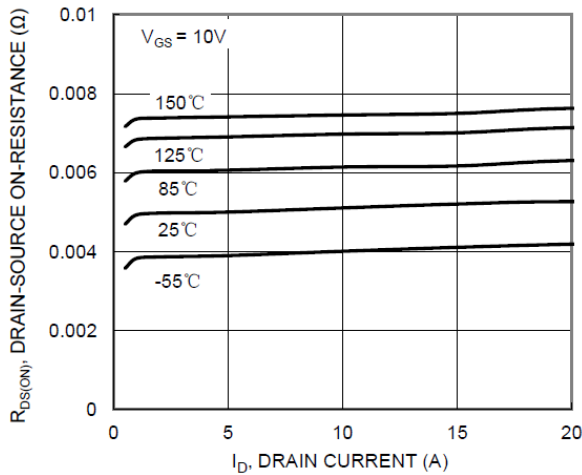


Figure 3. On-Resistance vs. Drain Current

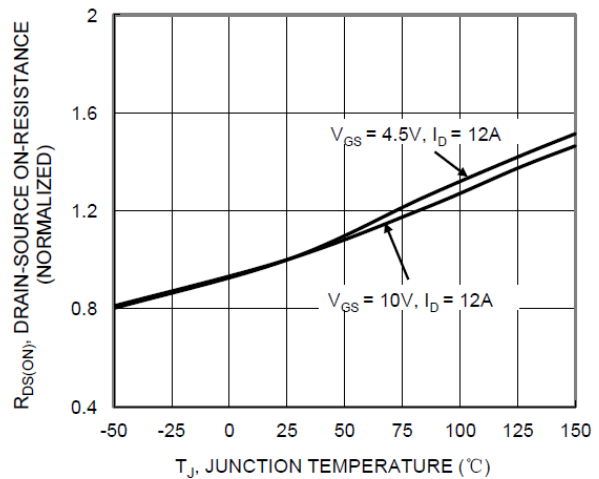


Figure 4. Normalized  $R_{DS(on)}$  vs.  $T_J$

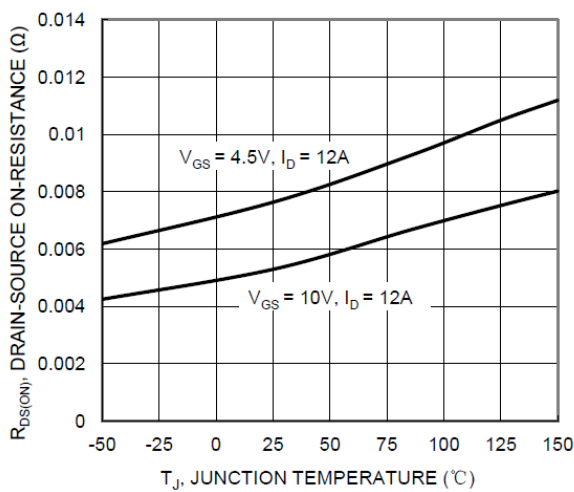


Figure 5. On-Resistance Variation with Temperature

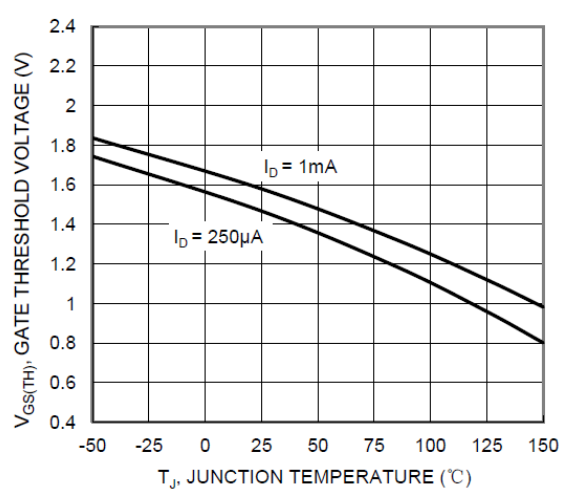


Figure 6. Gate Threshold Variation vs.  $T_J$

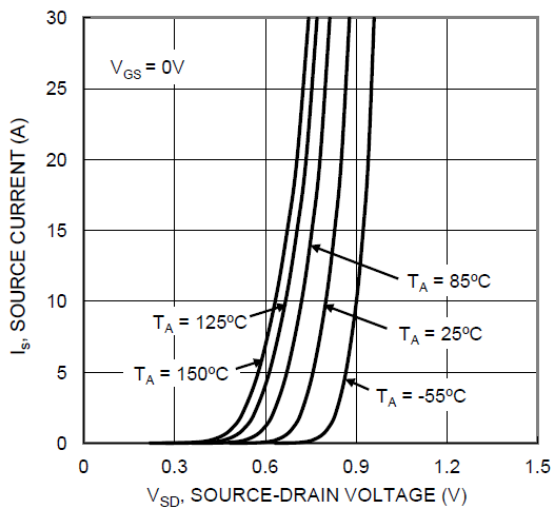


Figure 7. Diode Forward Voltage vs. Current

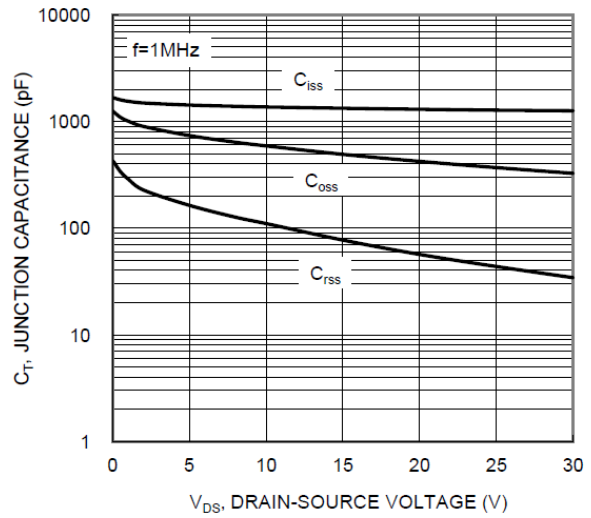


Figure 8. Capacitance

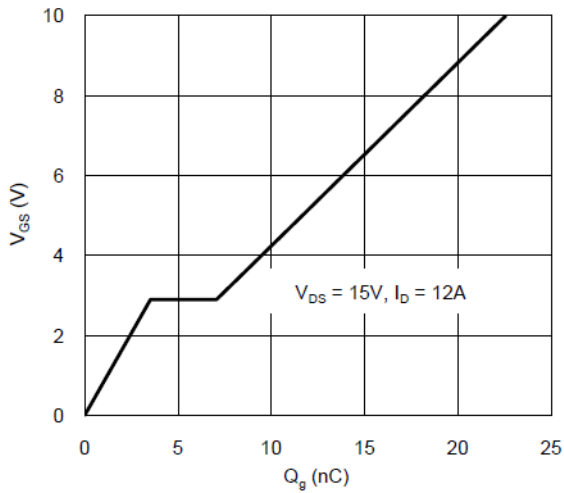


Figure 9. Gate Charge Waveform

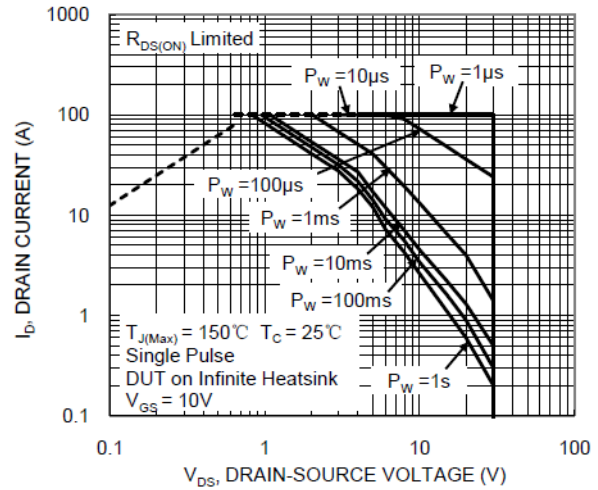


Figure 10. Maximum Safe Operating Area

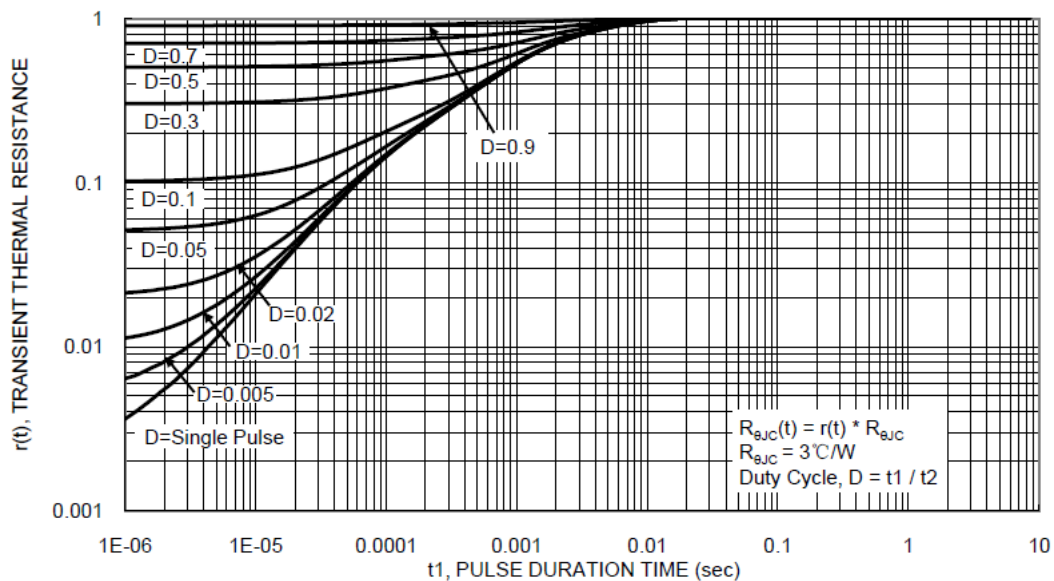
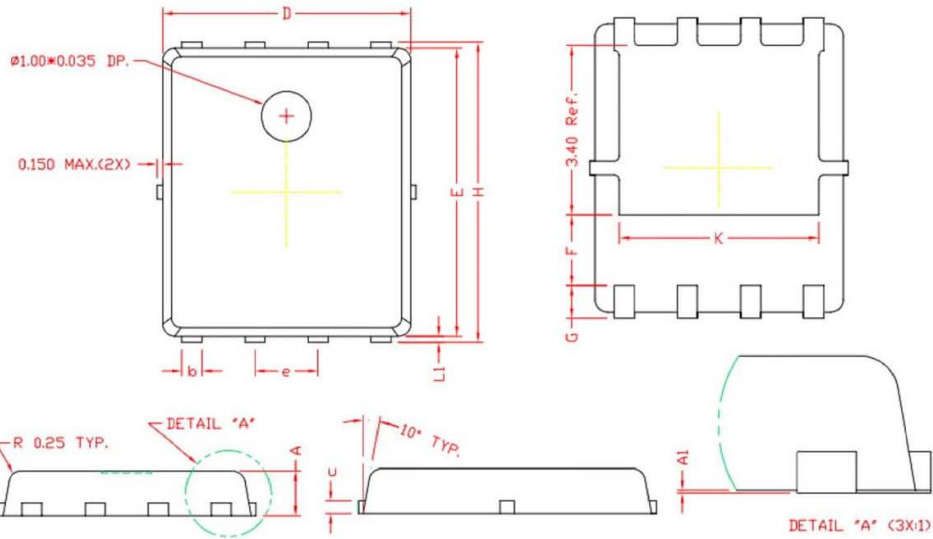


Figure 11. Normalized Transient Thermal Resistance

## Package Dimension

### DFN5x6-8L







### Dimensions



SYMBOL	Millimeters		Inches	
	MIN	MAX	MIN	MAX
A	0.800	1.000	0.031	0.039
A1	0.000	0.050	0.000	0.002
b	0.350	0.490	0.014	0.019
c	0.254 REF		0.010 REF	
D	4.900	5.100	0.193	0.201
F	1.400 REF		0.055 REF	
E	5.700	5.900	0.224	0.232
e	1.270 BSC		0.050 BSC	
H	5.950	6.200	0.234	0.244
L1	0.100	0.180	0.012	0.009
G	0.600 REF		0.024 REF	
K	4.000 REF		0.157 REF	

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